## Application/Control No. Applicant(s)/Patent Under Reexamination 10/780,764 IKEDA, MINORU Notice of References Cited Art Unit Examiner Page 1 of 1 Krista Soderholm 2826 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 257/080 \* US-2006/0054901 03-2006 Shoji et al. Α Harazono, Fumikazu 257/081 US-2004/0069998 04-2004 В 438/026 07-2004 Loh, Ban P. US-2004/0126913 С 257/099 US-2004/0075100 04-2004 Bogner et al. D US-Ε US-F US-G US-Н US-US-J

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